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				JOHN T. BERRY, ET AL.					
LIST OF SECTION CES CITED BY APPLICANT (Use Several Sheets if Necessary)				FILING DATE		GROUP ART UNIT			
				APRIL 16, 2004		2857 -2863			
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
	AA								
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FOREIGN PATENT DOCUMENTS									
•		DOCUMENT NUMBER	DATE	COUNTRY	COUNTRY			TRANSLATION YES NO	
	AC								
	AD								
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)									
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